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Critical currents at 77.3 K under magnetic fields up to 27 T for an Y-Ba-Cu-O film prepared by chemical vapor deposition

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Critical currents of an $\text{Y}_1\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ film prepared by a chemical vapor deposition technique have been measured resistively. Excellent critical current properties in high fields up to 27 T are obtained at 77.3 K. The value of J_c is 4.1×10^5 , 1.9×10^5 , and 6.5×10^4 A/cm² at 2, 10, and 27 T, respectively. The upper critical field defined by zero resistivity is estimated to be 35 and 180 T at 77.3 and 0 K, respectively. A peak effect in the critical current is observed at high fields.

Many studies on bulk samples of high T_c superconducting oxides such as Y-Ba-Cu-O,¹ Bi-Sr-Ca-Cu-O,² and Tl-Ba-Ca-Cu-O³ exhibited disappointingly low transport critical current density J_c measured resistively in magnetic fields. On the other hand, magnetization measurements on these superconducting oxides suggested higher values of J_c . This difference is thought to be related to the weak links at grain boundaries in superconducting oxides.⁴ Recently, several epitaxially grown thin films with well-aligned grains have been prepared by techniques of chemical vapor deposition (CVD),⁵ electron beam,⁶ and sputtering.⁷ It is expected that J_c increases in films with well-aligned grains, because of the reduction and quality improvement of grain boundaries.

In this letter, we report significantly high J_c in a newly prepared CVD sample of an epitaxially grown $\text{Y}_1\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ film up to 27 T at 77.3 K. The global pinning force $F_p = J_c \times B$ will be also discussed.

The details of the film preparation by CVD were reported in our previous paper.⁵ Source materials used were β -diketonate chelates of Y, Ba, and Cu. We succeeded in preparing $\text{Y}_1\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ films epitaxially on $\text{SrTiO}_3(100)$ single-crystal substrates at a deposition temperature as low as 850 °C. X-ray analysis confirmed a very strong c -axis orientation perpendicular to the substrate surface. In addition, a small intensity of b -axis grown perpendicular to the CVD film surface was observed. The sample dimension is about 1.8×10 mm² and 1 μ m thick. Current and voltage terminals were attached by ultrasonic soldering.

The transition temperature T_c and the upper critical field B_{c2} were determined from the resistive transition, which were measured in a temperature variable cryostat in zero or constant magnetic field. In measurements of critical currents, the sample was directly immersed in the liquid nitrogen. We used a pulsed power supply and measuring system developed by Sumitomo Electric Industries, Ltd. This system consisted of a programmable current supply (20 A, 16 V) and a digital oscilloscope (sampling, 250 MS/s). Critical currents were measured at the sweep rate of 10 A/0.5 s and by the sensitivity of 5 μ V/div through an isolation amplifier, and were decided by the voltage appearance. Magnetic fields were applied parallel to the film surface and perpendicular to the current by use of a hybrid magnet⁸ with a 52 mm room-temperature bore at Tohoku University.

Figure 1 shows a SEM photograph of the film surface including a fractured cross section. A very dense microstructure is observed in comparison with the previous sample⁵ which was deposited at 900 °C. Moreover, one notices numerous projections like needles on the film surface. These projections might correspond to b -axis diffraction in the x-ray analysis mentioned before. Detailed investigations on this strange microstructure are in progress.

Figure 2 indicates the resistive transitions in 0, 21, and 25 T. T_c , B_{c2} are determined from the extrapolation to the zero resistivity of the resistive transition. As can be seen, $T_c = 89$ K, $B_{c2}(82 \text{ K}) \approx 21$ T, and $B_{c2}(81 \text{ K}) \approx 25$ T, respectively. From these values, the slope of B_{c2} near T_c can be estimated to be about 3 T/K. From this result, the values of B_{c2} (T) at 77.3 K and 0 K are estimated to be 35 and 180 T, respectively, on the basis of the BCS-GLAG theory.

Figure 3 shows critical currents of the CVD film at 77.3 K and in magnetic fields up to 27 T. While the noise level in the measurements was about 1.2 μ V in the low-field region below 6 T, its level increased with increasing magnetic field, and reached about 11 μ V at 27 T. In this figure, errors of critical currents caused by this noise are indicated by vertical bars. As can be seen, these J_c properties at 77.3 K for this sample are very excellent. The critical current density values are $J_c = 4.1 \times 10^5$ A/cm² at 2.0 T, $J_c = 1.9 \times 10^5$ A/cm² at 10 T, and as high as $J_c = 6.5 \times 10^4$ A/cm² even at 27 T.

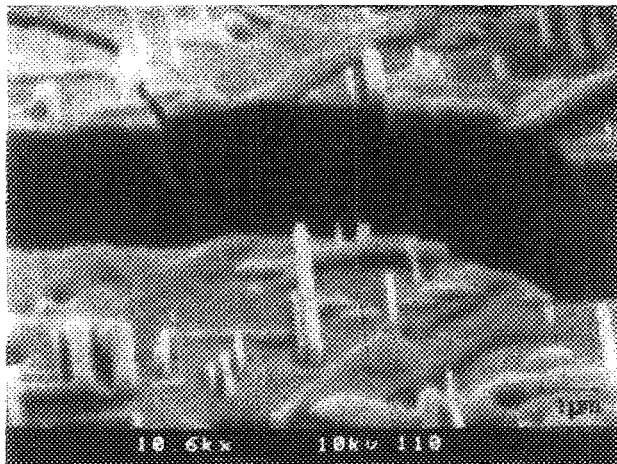


FIG. 1. Scanning electron micrograph of an epitaxially grown CVD $\text{Y}_1\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ film.

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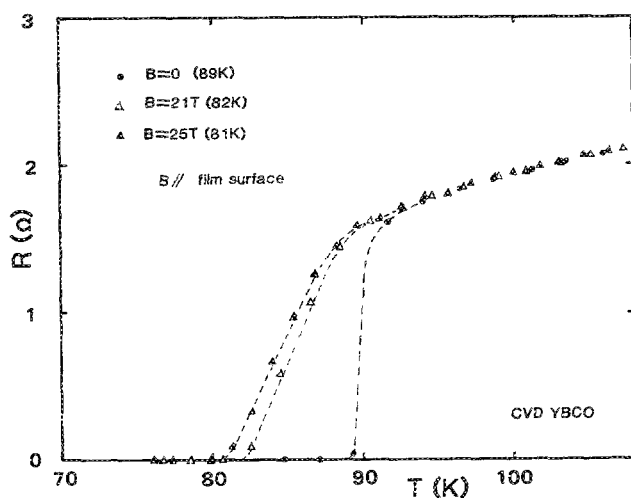


FIG. 2. Resistance vs temperature curves for the CVD Y-Ba-Cu-O film in $B = 0, 21$, and 25 T.

Moreover, in the high-field region more than 15 T, one should note a peak effect, which has been observed in several conventional superconductors such as NbN.⁹

Figure 4 shows the global pinning force F_p evaluated from $F_p = J'_c \times B$ at 77.3 K. We obtain a clear maximum of F_p near 9 T. Since B_{c2} at this temperature is 35 T, the reduced field $b = B/B_{c2}$ at the peak of F_p becomes about 0.26 . In addition, the peak effect in J'_c becomes clear in high fields more than 15 T.

The flux pinning curve except this peak effect resembles the data obtained by Kes *et al.*,¹⁰ who measured magnetization on a single crystal of $Y_1Ba_2Cu_3O_{7.6}$ at 20.4 K in fields up to 38 T by use of a pulsed magnet. They estimated the critical current densities from the hysteresis of the magnetization. According to their results, the reduced field $b = 0.31$ at the peak is indicated in the single crystal.

Recently, there are important discussions on the giant flux creep in high T_c superconducting oxides.¹¹ According

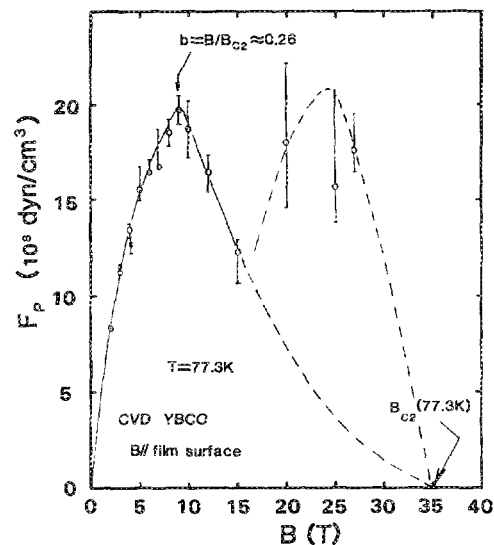


FIG. 4. Global pinning force at 77.3 K for the CVD Y-Ba-Cu-O film.

to Dew-Hughes,¹² the upper limit of J'_c due to the giant flux creep is about 3×10^3 A/cm² at 80 K and 2 T. Therefore, it is supposed that there exists strong flux pinning enough to suppress the giant flux creep in our CVD film sample which shows the excellent J'_c properties as shown in Fig. 3.

The peak effect in the magnetic field dependence of the critical current has been discussed in terms of the different flux pinning mechanism.¹³ Physical understanding for the peak effect in the vicinity of B_{c2} is not converged yet. Anyhow, we do not understand what kind of flux pinning is most effective in superconducting oxides. The excellent J'_c properties in our CVD film of $Y_1Ba_2Cu_3O_{7.6}$ might be associated with the strange microstructure including many projections as shown in Fig. 1.

In summary, the epitaxially grown $Y_1Ba_2Cu_3O_{7.6}$ film prepared by the CVD process exhibits excellent high J'_c properties at 77.3 K and in fields up to 27 T. The value of J'_c at 77.3 K is 4.1×10^5 , 1.9×10^5 , and 6.5×10^4 A/cm² at 2 , 10 , and 27 T, respectively. The upper critical field at 77.3 K is estimated to be 35 T. Moreover, we found a peak effect of J'_c . This peak effect may improve the J'_c ability in the very high magnetic fields at 77.3 K.

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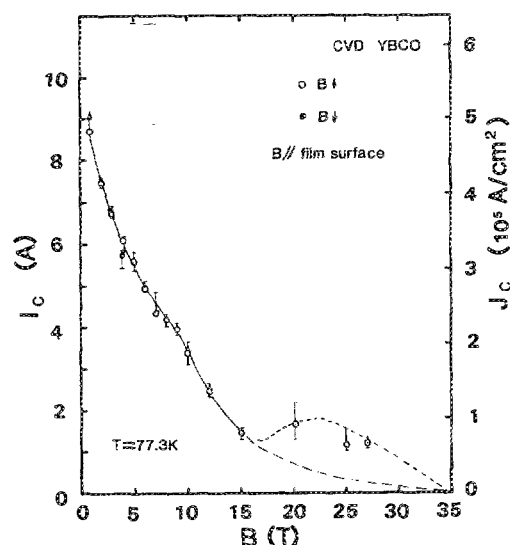


FIG. 3. Magnetic field dependence of critical currents at 77.3 K up to 27 T for the CVD Y-Ba-Cu-O film.

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